

# **Enhancement Mode N-Channel Power MOSFET**

 $TO-252/NMOS/30V/\pm20V/1.7V/60A/6.7m\Omega$ 

Rev2.2





# 30V, 6.7mΩ, 60A, Single N-Channel

#### 1.Features

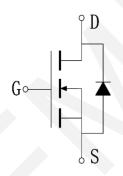
- ◆ 30V MOSFET technology
- ◆ Low on-state resistance
- ◆ Fast switching
- ♦ Vgs±20V

2.Ap	olication	าร
------	-----------	----

- ◆ Power Switching Application
- Load Switching



V <sub>DS</sub>	R <sub>DS(on)</sub> Typ.	I <sub>D</sub> Max.
201/	6.7mΩ @ 10V	CO 4
30V	14.5mΩ @ 4.5V	60A



Schematic Diagram

### 3. Package Marking and Ordering Information

Part no.	Marking	Package PCS/Reel		PCS/CTN.
WP3060A	WP3060A	TO-252	2,500	25,000

## 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V <sub>DSS</sub>	30	V
Gate to Source Voltage	$V_{GSS}$	±20	V
Drain Current (DC)	ID	60	А
Drain Current (Pulse), PW≤300μs	I <sub>DP</sub>	162	А
Total Dissipation	P <sub>D</sub>	60	W
Avalanche Energy, Single Pulsed	Eas	100	mJ
Junction Temperature	Tj	175	°C
Storage Temperature	T <sub>stg</sub>	-55 to +175	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### 5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Junction to case	Rejc	2.5	°C/W

Note 2: When mounted on 1 inch square copper board  $t \le 10$ sec The value in any given application depends on the user's specific board design.

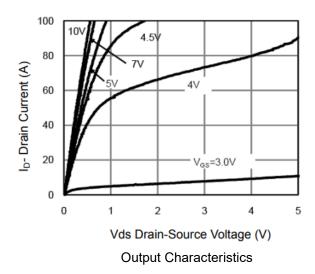
### 6.Electrical Characteristics at Ta=25°C (Note 3)

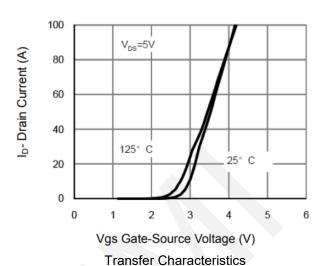
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$I_D = 250 \mu A, V_{GS} = 0 V$	30	34		V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V			1	μΑ
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V$ , $V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250µA	1.0	1.7	2.5	V
Static Drain to Source On-State	Б	I <sub>D</sub> = 20A, V <sub>GS</sub> = 10V		6.7	10.9	mΩ
Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 10A, V <sub>GS</sub> = 4.5V		17.5	40	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V,		2000		pF
Output Capacitance	Coss	V <sub>DS</sub> =15V,		280		pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz		210		pF
Turn-ON Delay Time	t <sub>d(on)</sub>			10		ns
Rise Time	tr	V <sub>DD</sub> = 15V, I <sub>DS</sub> = 20A,		8		ns
Turn-OFF Delay Time	t <sub>d(off)</sub>	$V_{GS} = 10V, R_G = 1.8\Omega$		25		ns
Fall Time	t <sub>f</sub>			5		ns
Total Gate Charge	Qg	V <sub>DS</sub> = 10V, V <sub>GS</sub> = 10V,		32.3		nC
	Qgs			4.9		nC
	Q <sub>gd</sub>	I <sub>DS</sub> = 20A		6.9		nC
Diode Forward Voltage	$V_{FSD}$	I <sub>S</sub> = 20A, V <sub>GS</sub> = 0		0.85	1.2	V

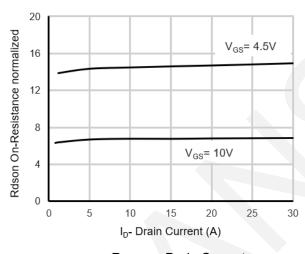
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

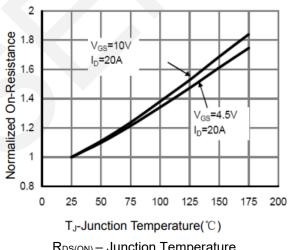


#### 7. Typical electrical and thermal characteristics



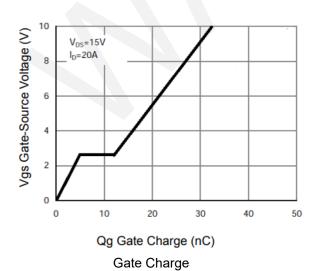


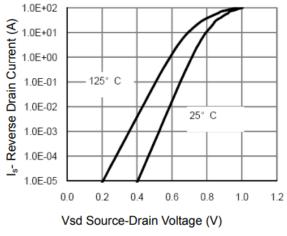






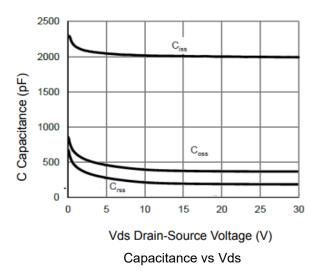


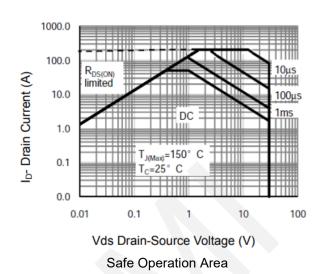


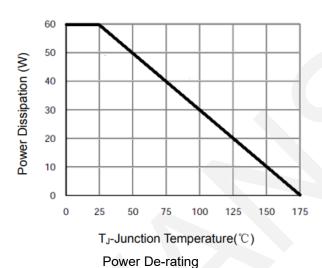


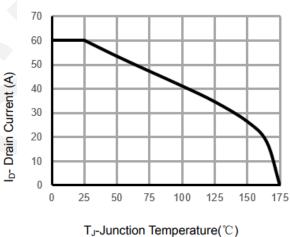
Source - Drain Diode Forward



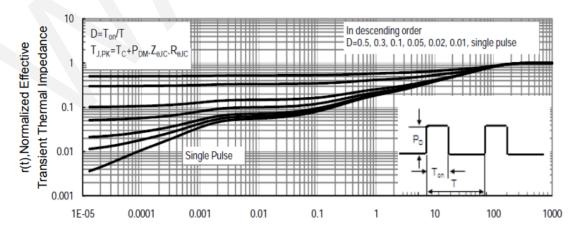








ID Current – Junction Temperature

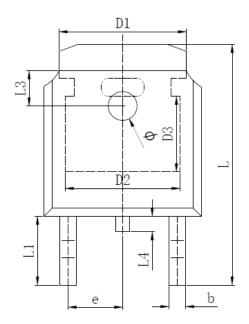


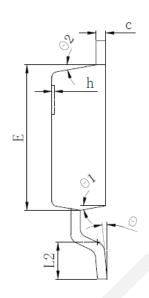
Square Wave Pluse Duration(sec)

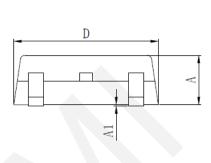
Normalized Maximum Transient Thermal Impedance



# 8.Package Dimensions







SYMBOL	MILLIMETER			
SIMDUL	MIN	Typ.	MAX	
A	2. 200	2. 300	2. 400	
A1	0.000		0. 127	
b	0.640	0.690	0.740	
c(电镀后)	0. 460	0. 520	0. 580	
D	6. 500	6. 600	6. 700	
D1		5.334 REF		
D2		4.826 REF		
D3	3.166 REF			
E	6. 000	6. 100	6. 200	
е	2.286 TYP			
h	0.000	0.100	0. 200	
L	9. 900	10. 100	10. 300	
L1	2.888 REF			
L2	1. 400	1. 550	1. 700	
L3	1.600 REF			
L4	0.600	0.800	1. 000	
ф	1. 100	1. 200	1. 300	
θ	0°		8°	
θ1	9° TYP			
θ2	9° TYP			



#### 9. Important Notice

WAN SEMICONDUCTOR (NINGBO) CO.,LTD reserves the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services and to discontinue any product or service. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to WANSEMI's terms and conditions of sale supplied at the time of order acknowledgment.

WANSEMI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in WANSEMI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent WANSEMI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

WANSEMI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using WANSEMI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

No WANSEMI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Unless WANSEMI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use, WANSEMI will not be responsible for any failure of such components to meet such requirements.